## Notice of References Cited

Application/Control No.

10/632,258

Examiner

Khoa D. Huynh

Applicant(s)/Patent Under
Reexamination
DE LEON ET AL.

Art Unit
Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	А	US-5,375,271	12-1994	Frankel, Gail B.	4/581
*	В	US-4,675,015	06-1987	Brown, Alice	604/385.09
*	С	US-6,174,581	01-2001	Barker, Hedy	428/43
*	D	US-6,763,531	07-2004	Huffman et al.	4/251.1
*	E	US-6,295,658	10-2001	Jenkins, Matthew	4/251.1
*	F	US-5,379,558	01-1995	Mason, III, Russell E.	52/105
*	G	US-6,652,947	11-2003	Sweeney et al.	428/43
*	Н	US-3,657,745	04-1972	Hickman, Ronald P.	4/483
	ı	US-			
	J	US-			,
	К	US-			•
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
,	Р					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	V	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.